

AOTF296L

100V N-Channel MOSFET

General Description

Trench Power MV MOSFET technology

- Low R_{DS(ON)}
- Low Gate Charge

Applications

Optimized for fast-switching applications

Product Summary

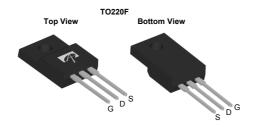
 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 41A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 10 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 6V) & < 12.5 m\Omega \end{array}$

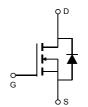
100% UIS Tested 100% Rg Tested

Synchronous Rectification in DC/DC and AC/DC Converters

Industrial and Motor Drive applications







Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOTF296L	TO-220F	Tube	1000

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain	T _C =25°C	I_	41		
Current	T _C =100°C	I _D	29	A	
Pulsed Drain Current C		I _{DM}	160		
Continuous Drain	T _A =25°C	l	10	А	
Current	T _A =70°C	IDSM	8	^	
Avalanche Current ^C		I _{AS}	40	А	
Avalanche energy L=0.1mH ^C		E _{AS}	80	mJ	
V _{DS} Spike	10µs	V _{SPIKE}	120	V	
	T _C =25°C	P _D	36.5	W	
Power Dissipation ^B	T _C =100°C	T _D	18	VV	
	T _A =25°C	р	2.2	w	
Power Dissipation A	T _A =70°C	P _{DSM}	1.4		
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	В	10	15	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	45	55	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	3.4	4.1	°C/W	

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS	•			•	•	
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		100			V
l	I _{DSS} Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V				1	μA
IDSS			T _J =55°C			5	
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D=250\mu A$		2.3	2.9	3.4	V
		V _{GS} =10V, I _D =20A			8.2	10	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance		T _J =125°C		14.2	17.2	11177
		V _{GS} =6V, I _D =20A			9.7	12.5	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			62		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V
Is	Maximum Body-Diode Continuous Curr	rent			41	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, f=1MHz			2785		pF
Coss	Output Capacitance				238		pF
C _{rss}	Reverse Transfer Capacitance				12		pF
R_g	Gate resistance	f=1MHz		0.25	0.55	0.85	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =20A			37	52	nC
Q_{gs}	Gate Source Charge				11.5		nC
Q_{gd}	Gate Drain Charge				5		nC
$t_{D(on)}$	Turn-On DelayTime				13		ns
t_r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =2 Ω , R_{GEN} =3 Ω			8.5		ns
$t_{D(off)}$	Turn-Off DelayTime				29		ns
t_f	Turn-Off Fall Time				4		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs			35		ns
Q_{rr}	Body Diode Reverse Recovery Charge	e I _F =20A, dI/dt=500A/μs		-	210		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{0JA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175 $^{\circ}\,$ C may be used if the PCB allows it.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}\text{=}175^{\circ}\,$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

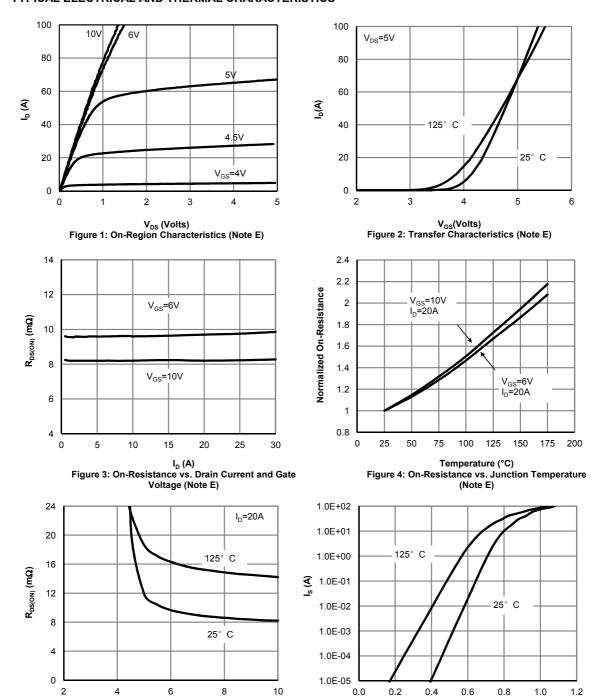
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

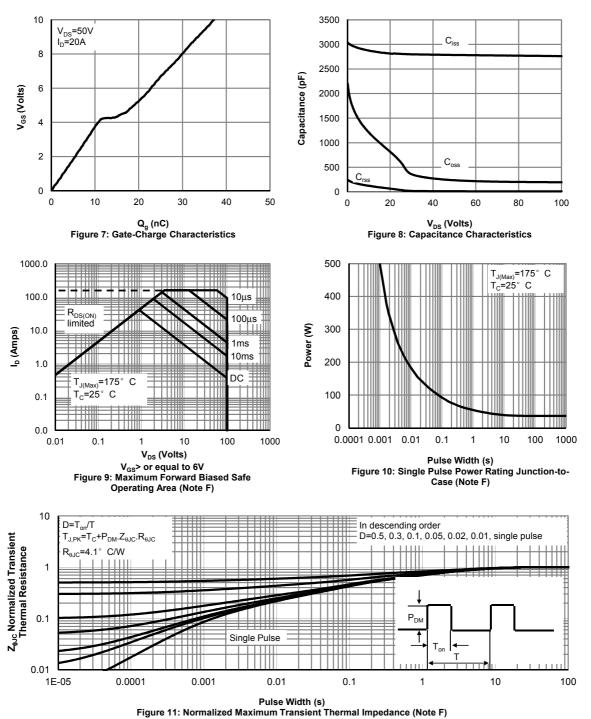
V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage

(Note E)

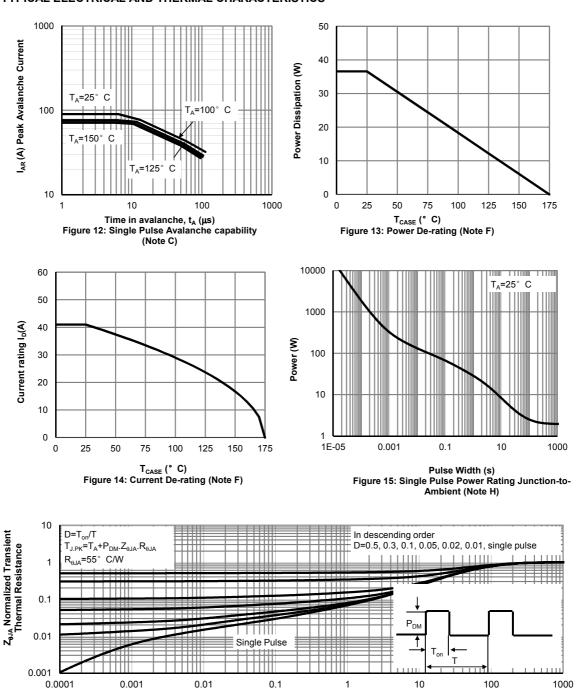


V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

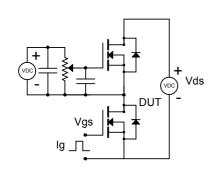


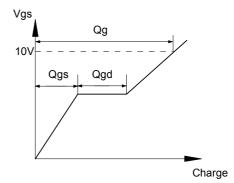
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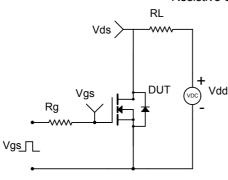
Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

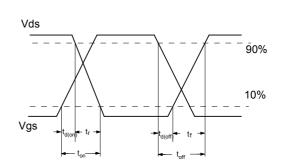
Gate Charge Test Circuit & Waveform



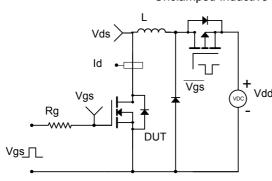


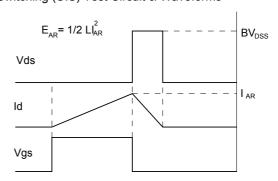
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

